

### **General Description**

The SIR104LDP-T1-RE3 use advanced SGT MOSFET technology to provide low RDS(ON), low gate charge, fast switching and excellent avalanche characteristics. This device is specially designed to get better ruggedness and suitable.

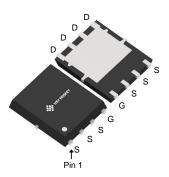
#### **General Features**

V<sub>DS</sub> =85V I<sub>D</sub> =100A

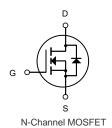
 $R_{DS(ON)} < 5.6 m\Omega @ V_{GS} = 10V$ 

## **Applications**

Consumer electronic power supply Motor control
Synchronous-rectification Isolated DC
Synchronous-rectification applications



DFN5X6-8L (DFN-8(5.2x5.9))



## **Package Marking and Ordering Information**

Product ID	Pack	Brand	Qty(PCS)
SIR104LDP-T1-RE3	DFN5X6-8L(DFN-8(5.2x5.9))	HXY MOSFET	5000

## Absolute Maximum Ratings (T<sub>c</sub>=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
V <sub>D</sub> s	Drain-Source Voltage	85	V
Vgs	Gate-Source Voltage	±20	V
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	100	А
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	63.3	А
Ірм	Pulsed Drain Current <sup>2</sup>	400	А
EAS	Single Pulse Avalanche Energy <sup>3</sup>	273.8	mJ
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>4</sup>	107.8	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Rejc	Thermal Resistance from Junction-to-Ambient <sup>3</sup>	1.16	°C/W
$R_{\theta}$ JA	Thermal Resistance Junction-Ambient <sup>1</sup>	60	°C/W



## Electrical Characteristics (T<sub>J</sub> = 25°C, unless otherwise noted)

Parameter		Symbol	mbol Test Conditions		Тур.	Max.	Unit
Static Characteristics				1	1	•	
Drain-Source Breakdown Voltage		V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	85	-	-	V
Gate-body Leakage current		Igss	V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±20V	-	-	±100	nA
Zero Gate Voltage Drain Current	T <sub>J</sub> =25°C	1	V <sub>DS</sub> = 85V, V <sub>GS</sub> = 0V	-	-	1	μΑ
	T <sub>J</sub> =100°C	I <sub>DSS</sub>		-	-	100	
Gate-Threshold Voltage		V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	2	3	4	V
Drain-Source on-Resistance <sup>4</sup>		R <sub>DS(on)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 20A	-	4.3	5.6	mΩ
Forward Transconductance <sup>4</sup>		<b>G</b> fs	V <sub>DS</sub> = 5V, I <sub>D</sub> =20A	-	57.8	-	S
Dynamic Characteristic	s <sup>5</sup>			•		•	
Input Capacitance		C <sub>iss</sub>		-	4645	-	pF
Output Capacitance		Coss	V <sub>DS</sub> = 40V, V <sub>GS</sub> =0V, f =1MHz	-	673	-	
Reverse Transfer Capacitance		Crss		-	41	-	
Gate Resistance		Rg	f=1MHz	-	2.0	-	Ω
Switching Characteristi	CS <sup>5</sup>			•		•	
Total Gate Charge		Qg		-	61.3	-	nC
Gate-Source Charge		Qgs	$V_{GS} = 10V, V_{DS} = 40V,$ $I_{D} = 20A$	-	21	-	
Gate-Drain Charge		Q <sub>gd</sub>		-	11	-	
Turn-on Delay Time		t <sub>d(on)</sub>		-	16.5	-	. ns
Rise Time		t <sub>r</sub>	V <sub>GS</sub> =10V, V <sub>DD</sub> = 40V,	-	51.8	-	
Turn-off Delay Time		t <sub>d(off)</sub>	$R_G = 3\Omega$ , $I_D = 20A$	-	37.1	-	
Fall Time		t <sub>f</sub>		-	8.2	-	
Body Diode Reverse Recovery Time		t <sub>rr</sub>		-	69	-	ns
Body Diode Reverse Recovery Charge		Qrr	- I <sub>F</sub> =20A, di/dt = 100A/μS	-	141	-	nC
Drain-Source Body Dio	de Characte	eristics					
Diode Forward Voltage <sup>4</sup>		V <sub>SD</sub>	I <sub>S</sub> = 20A, V <sub>GS</sub> = 0V	-	-	1.2	V
Continuous Source Current	T <sub>C</sub> =25°C	Is	-	-	-	100	Α

#### Notes:

- 1. Repetitive rating, pulse width limited by junction temperature  $TJ(MAX)=150^{\circ}C$
- 2. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =50V,  $V_{GS}$ =10V, L=0.4mH,  $I_{AS}$ =37A
- 3. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
- 4. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.
- 5. This value is guaranteed by design hence it is not included in the production test.



# **Typical Characteristics**

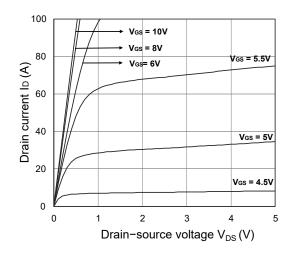


Figure 1. Output Characteristics

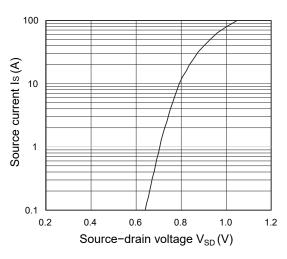


Figure 3. Forward Characteristics of Reverse

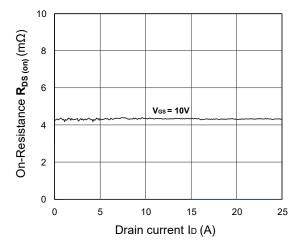


Figure 5.  $R_{DS(ON)}$  vs.  $I_D$ 

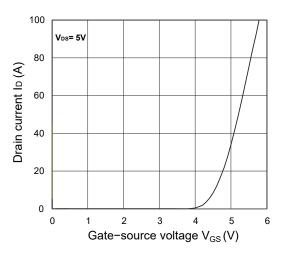


Figure 2. Transfer Characteristics

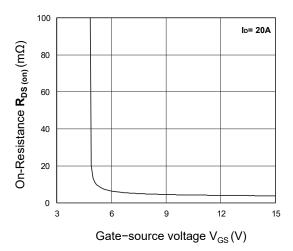


Figure 4.  $R_{DS(ON)}$  vs.  $V_{GS}$ 

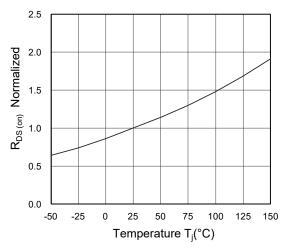


Figure 6. Normalized  $R_{DS(on)}$  vs. Temperature

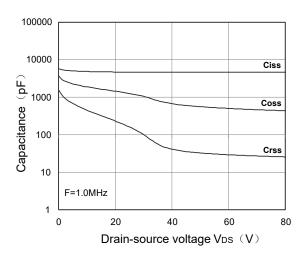
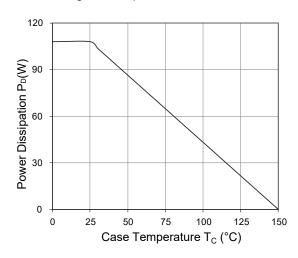


Figure 7. Capacitance Characteristics

Figure 8. Gate Charge Characteristics



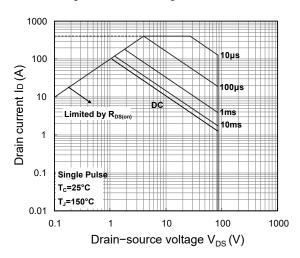


Figure 9. Power Dissipation

Figure 10. Safe Operating Area

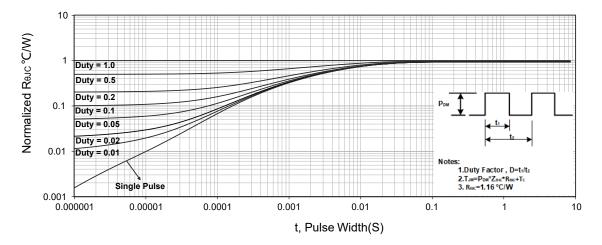
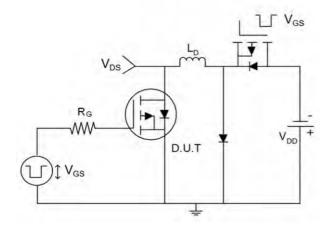
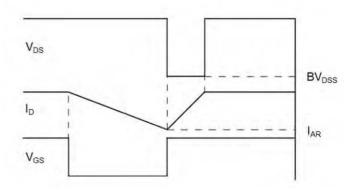


Figure 11. Normalized Maximum Transient Thermal Impedance

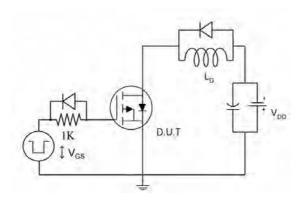


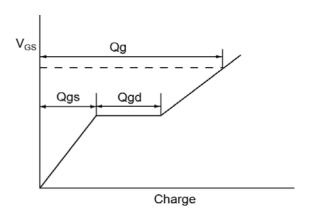
# 1) E<sub>AS</sub> Test Circuits



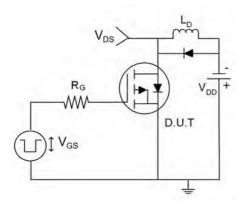


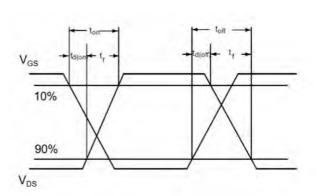
## 2) Gate Charge Test Circuit





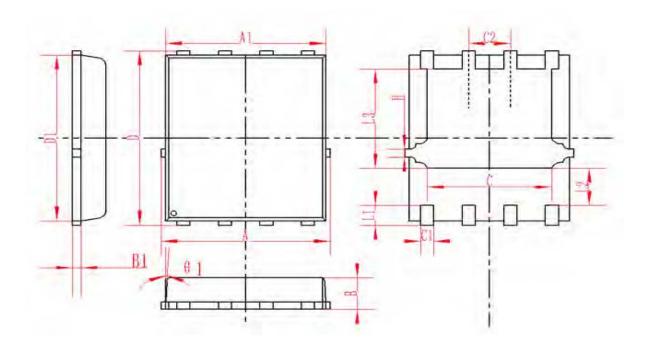
## 3) Switch Time Test Circuit







# DFN5X6-8L(DFN-8(5.2x5.9)) Package Information



SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX
А	4.95	5	5.05	0.195	0.197	0.199
A1	4.82	4.9	4.98	0.190	0.193	0.196
D	5.98	6	6.02	0.235	0.236	0.237
D1	5.67	5.75	5.83	0.223	0.226	0.230
В	0.9	0.95	1	0.035	0.037	0.039
B1	0.254REF		0.010REF			
С	3.95	4	4.05	0.156	0.157	0.159
C1	0.35	0.4	0.45	0.014	0.016	0.018
C2		1.27TYP			0.5TYP	
θ1	8°	10°	12°	8°	10°	12°
L1	0.63	0.64	0.65	0.025	0.025	0.026
L2	1.2	1.3	1.4	0.047	0.051	0.055
L3	3.415	3.42	3.425	0.134	0.135	0.135
Н	0.24	0.25	0.26	0.009	0.010	0.010



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